

M36W0Rx0x0x7

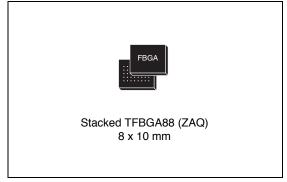
32- or 64-Mbit (2 or 4 Mbits x 16, multiple bank, burst) flash memory and 8-Mbit (512 Kbit x16) or 16-Mbit (1 Mbit x 16) PSRAM MCP

Features

- Multichip package
 - 1 die of 32 or 64 Mbits (2 or 4 Mbits x 16) flash memory
 - 1 die of 8 Mbits (512 Kbits x 16) or 16 Mbits (1 Mbit x 16) PSRAM
- Supply voltage
 - $V_{DDF} = V_{DDQ} = V_{DDP} = 1.7 \text{ V to } 1.95 \text{ V}$
- Electronic signature
 - Manufacturer code: 20h
 - Device codes (32-Mbit flash device)
 Top M36W0R5030T7 and
 M36W0R5040T7: 8814h
 Bottom M36W0R5030B7 and
 M36W0R5040B7: 8815h
 - Device codes (8-Mbit flash devices)
 Top M36W0R6040T7: 8810h
 Bottom M36W0R6040B7: 8811h
- Density and Packaging:
 - RoHS compliant

Flash memory

- Programming time
 - 10 μs by word typical for fast factory program
 - Double/quadruple word program option
- Memory blocks
 - Multiple bank memory array: 4-Mbit banks
 - Parameter blocks (top or bottom location)
- Synchronous/asynchronous read
 - Synchronous burst read mode: 66 MHz
 - Asynchronous page read mode
 - Random access times: 70 ns
- Synchronous burst read suspend
- Dual operations
 - Program erase in 1 bank, read in others
 - No delay between read and write operations



- Block locking
 - All blocks locked at power-up
 - Any combination of blocks can be locked
 - WP for block lock-down
- Security
 - 128-bit user programmable OTP cells
 - 64-bit unique device number
- Common flash interface (CFI)
- 100,000 program/erase cycles per block

PSRAM

■ Access time: 60 ns

■ Low standby current: 70 μ A

■ Deep power-down current: 10 μ A

Table 1. Device summary

	•						
M36W0Rx0x0x7							
M36W0R5030T7	M36W0R5030B7						
M36W0R5040T7	M36W0R5040B7						
M36W0R6040T7	M36W0R6040B7						

April 2009 209220 - Rev 3 1/24

Contents M36W0Rx0x0x7

Contents

1	Desc	ription
2	Signa	al descriptions10
	2.1	Address inputs (A0-A21)
	2.2	Data input/output (DQ0-DQ15)
	2.3	Flash Chip Enable ($\overline{\overline{E}}_F$)
	2.4	Flash Output Enable (\overline{G}_F)
	2.5	Flash Write Enable (\overline{W}_F)
	2.6	Flash Write Protect (WP _F)
	2.7	Flash Reset (RP _F)
	2.8	Flash Latch Enable (\overline{L}_{F})
	2.9	Flash Clock (K _F)
	2.10	Flash Wait (WAIT _F)
	2.11	PSRAM Chip Enable (\overline{E}_{P})
	2.12	PSRAM Output Enable (\overline{G}_P)
	2.13	PSRAM Write Enable (\overline{W}_P)
	2.14	PSRAM Upper Byte Enable (UB _P)
	2.15	PSRAM Lower Byte Enable ($\overline{\text{LB}}_{\text{P}}$)
	2.16	V _{DDF} supply voltage
	2.17	V _{DDP} supply voltage
	2.18	V _{DDQ} supply voltage
	2.19	V _{PPF} program supply voltage
	2.20	V _{SS} ground
3	Func	tional description14
4	Maxi	mum ratings
5	DC a	nd AC parameters
6	Pack	age mechanical
7	Part :	numbering
2/24		N numonyx

M36W0Rx0	x0x7	Co	ontents
8	Revision history		23

Numonyx 3/24

List of tables M36W0Rx0x0x7

List of tables

Table 1.	Device summary	1
Table 2.	Signal names	8
Table 3.	Main operating modes	. 16
Table 4.	Absolute maximum ratings	. 17
Table 5.	Operating and AC measurement conditions	. 18
Table 6.	Device capacitance	. 19
Table 7.	Stacked TFBGA88 8 x 10 mm - 8 x 10 ball array, 0.8 mm pitch, package	
	mechanical data	. 21
Table 8.	Ordering information scheme	. 22
Table 9.	Document revision history	. 23

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M36W0Rx0x0x7 List of figures

List of figures

Figure 1.	Logic diagram	. 7
Figure 2.	TFBGA connections (top view through package)	. 9
Figure 3.	Functional block diagram	15
Figure 4.	AC measurement I/O waveform	18
Figure 5.	AC measurement load circuit	19
Figure 6.	Stacked TFBGA88 8 x 10 mm - 8 x 10 active ball array, 0.8 mm pitch, package outline	20

Numonyx 5/24

Description M36W0Rx0x0x7

1 Description

The M36W0R5030x7, M36W0R5040x7, and M36W0R6040x7 combine two memory devices in a multichip package:

- a 32- or 64-Mbit, multiple bank flash memory, the M58WR032KT/B or M58WR064KT/B, respectively.
- a 8- or 16-Mbit PSRAM, the M69KB012AB or M69KB024AB, respectively.

Recommended operating conditions do not allow more than one memory to be active at the same time.

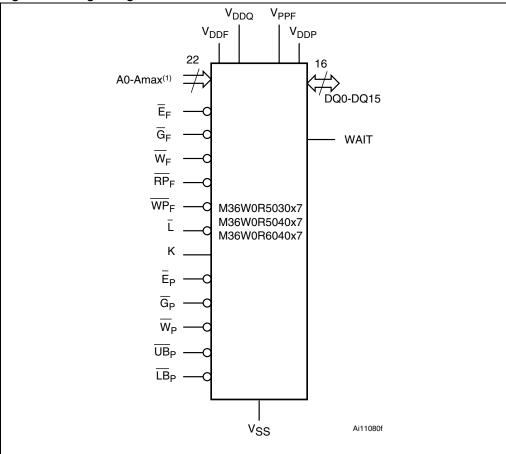
The purpose of this document is to describe how the two memory components operate with respect to each other. It must be read in conjunction with the datasheets of the M58WR032KT/B or M58WR064KT/B, and M69KB012AB or M69KB024AB, respectively, which fully detail all the specifications required to operate the flash memory and PSRAM components.

The memory is offered in a stacked TFBGA88 (8 x 10 mm, 8 x 10 ball array, 0.8 mm pitch) package, and is supplied with all the bits erased (set to '1').

6/24 Numonyx

M36W0Rx0x0x7 Description

Figure 1. Logic diagram



1. Amax is equal to A20 in the M36W0R50x0x7 and A21 in the M36W0R6040x7.

Numonyx 7/24

Description M36W0Rx0x0x7

Table 2. Signal names⁽¹⁾

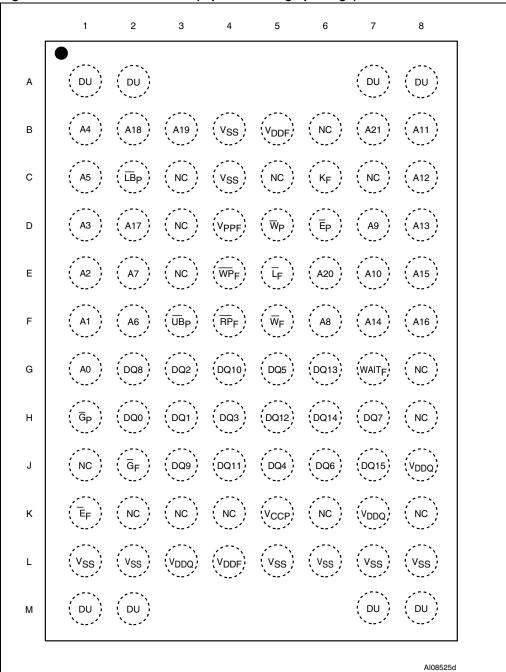
Name	Function					
A0-A18	Common address inputs					
DQ0-DQ15	Common data input/output					
V_{DDF}	Flash Memory power supply					
V_{DDQ}	Common flash and PSRAM power supply for I/O buffers					
V _{PPF}	Common flash optional supply voltage for fast program and erase					
V _{SS}	Ground					
V _{CCP}	PSRAM power supply					
NC	Not connected internally					
DU	Do not use as internally connected					
Flash memory con	trol functions					
A19-A20, A20, or A20-A21 ⁽²⁾	Address inputs for the flash memory only					
Ē _F	Chip Enable input					
Ḡ _F	Output Enable input					
Ī _F	Latch Enable input					
K _F	Burst Clock					
WAIT _F	Wait data in burst mode					
\overline{W}_F	Write Enable input					
RP _F	Reset input					
WP _F	Write Protect input					
PSRAM control fur	nctions					
Ē _P	Chip Enable input					
G _P	Output Enable input					
\overline{W}_{P}	Write Enable input					
ŪB _P	Upper Byte Enable input					
ĪB _P	Lower Byte Enable input					

A0-A18 (in the case of an 8-Mbit PSRAM) or A0-A19 (in the case of a 16-Mbit PSRAM) are common to the flash memory and the PSRAM.

^{2.} A19-A20 for the M36W0R5030x7, A20 for the M36W0R5040x7, and A20-A21 for the M36W0R6040x7.

M36W0Rx0x0x7 Description

Figure 2. TFBGA connections (top view through package)



Numonyx 9/24

Signal descriptions M36W0Rx0x0x7

2 Signal descriptions

See Figure 1: Logic diagram and Table 2: Signal names for a brief overview of the signals connected to this device.

2.1 Address inputs (A0-A21)

Addresses A0-A18 are common inputs for the flash memory and PSRAM components. The address inputs select the cells in the memory array to access during bus read operations. During bus write operations they control the commands sent to the command interface of the flash memory program/erase controller, and they select the cells to access in the PSRAM.

Addresses A19-A20 (for the M36W0R5030x7), A20 (for the M36W0R5040x7), and A20-A21 (for the M36W0R6040x7) are inputs for the flash memory component only. The flash memory is accessed through the Chip Enable signals ($\overline{\mathbb{E}}_{F}$) and through the Write Enable ($\overline{\mathbb{W}}_{F}$) signal.

2.2 Data input/output (DQ0-DQ15)

For the flash memory, the data I/O outputs the data stored at the selected address during a bus read operation or inputs a command or the data to be programmed during a write bus operation.

For the PSRAM, the upper byte data inputs/outputs carry the data to or from the upper part of the selected address during a write or read operation, when upper byte enable $(\overline{\sf UB}_{\sf P})$ is driven Low.

Likewise, the lower byte data inputs/outputs carry the data to or from the lower part of the selected address during a write or read operation, when Lower Byte Enable ($\overline{\text{LB}}_{P}$) is driven Low.

2.3 Flash Chip Enable (\overline{E}_F)

The Chip Enable inputs activate the memory control logics, input buffers, decoders and sense amplifiers. When Chip Enable is Low, $V_{\rm IL}$, and Reset is High, $V_{\rm IH}$, the device is in active mode. When Chip Enable is at $V_{\rm IH}$ the flash memory is deselected, the outputs are high impedance and the power consumption is reduced to the standby level.

2.4 Flash Output Enable (\overline{G}_{F})

The Output Enable pins control data outputs during flash memory bus read operations.

2.5 Flash Write Enable (\overline{W}_{F})

The Write Enable controls the bus write operation of the flash memories' command interface. The data and address inputs are latched on the rising edge of Chip Enable or Write Enable, whichever occurs first.

10/24 **№** numonyx

2.6 Flash Write Protect (\overline{WP}_F)

Write Protect is an input that gives an additional hardware protection for each block. When Write Protect is Low, V_{IL} , lock-down is enabled and the protection status of the locked-down blocks cannot be changed. When Write Protect is at High, V_{IH} , lock-down is disabled and the locked-down blocks can be locked or unlocked (refer to the lock status table in M58WR032KT/B and M58WR064KT/B datasheet).

2.7 Flash Reset (\overline{RP}_F)

The Reset input provides a hardware reset of the memory. When Reset is at V_{IL} , the memory is in reset mode: the outputs are high impedance and the current consumption is reduced to the Reset supply current I_{DD2} . Refer to the M58WR032KT/B or M58WR064KT/B datasheet for the value of IDD2. After Reset all blocks are in the locked state and the configuration register is reset. When Reset is at V_{IH} , the device is in normal operation. Upon exiting reset mode the device enters asynchronous read mode, but a negative transition of Chip Enable or Latch Enable is required to ensure valid data outputs.

The Reset pin can be interfaced with 3 V logic without any additional circuitry. It can be tied to V_{BPH} (refer to the M58WR032KT/B or M58WR064KT/B datasheet).

2.8 Flash Latch Enable (\overline{L}_F)

Latch Enable latches the address bits on its rising edge. The address latch is transparent when Latch Enable is Low, V_{IL} , and it is inhibited when Latch Enable is High, V_{IH} . Latch Enable can be kept Low (also at board level) when the Latch Enable function is not required or supported.

2.9 Flash Clock (K_F)

The Clock input synchronizes the flash memory to the microcontroller during synchronous read operations; the address is latched on a Clock edge (rising or falling, according to the configuration settings) when Latch Enable is at V_{IL}. Clock is 'don't care' during asynchronous read and in write operations.

2.10 Flash Wait (WAIT_F)

WAIT is a flash output signal used during synchronous read to indicate whether the data on the output bus are valid. This output is high impedance when flash Chip Enable is at V_{IL} or flash Reset is at V_{IL} . It can be configured to be active during the wait cycle or one clock cycle in advance. The WAIT_F signal is not gated by Output Enable.

2.11 PSRAM Chip Enable (\overline{E}_P)

When asserted (Low), the Chip Enable, $\overline{E}_{P,}$ activates the memory state machine, address buffers and decoders, allowing read and write operations to be performed. When deasserted (High), all other pins are ignored and the device is automatically put in low-power standby mode.

Numonyx

11/24

Signal descriptions M36W0Rx0x0x7

2.12 PSRAM Output Enable (\overline{G}_P)

The Output Enable, \overline{G}_P , provides a high speed tri-state control, allowing fast read/write cycles to be achieved with the common I/O data bus.

2.13 PSRAM Write Enable (\overline{W}_P)

The Write Enable, \overline{W}_{P} , controls the bus write operation of the memory.

2.14 PSRAM Upper Byte Enable (UB_P)

The Upper Byte Enable, $\overline{\text{UB}}_{\text{P}}$, gates the data on the upper byte data inputs/outputs (DQ8-DQ15) to or from the upper part of the selected address during a write or read operation.

2.15 PSRAM Lower Byte Enable (\overline{LB}_P)

The Lower Byte Enable, \overline{LB}_P , gates the data on the lower byte data inputs/outputs (DQ0-DQ7) to or from the lower part of the selected address during a write or read operation.

2.16 V_{DDF} supply voltage

V_{DDF} provides the power supply to the internal core of the flash memory component. It is the main power supplies for all flash memory operations (read, program, and erase).

2.17 V_{DDP} supply voltage

The V_{DDP} supply voltage supplies the power for all operations (read or write) and for driving the refresh logic, even when the device is not being accessed.

2.18 V_{DDQ} supply voltage

 V_{DDQ} provides the power supply for the flash memory and PSRAM I/O pins. This allows all outputs to be powered independently of the flash memory and PSRAM core power supplies: V_{DDF} and V_{DDP} , respectively.

12/24 N ∩umonyx

2.19 V_{PPF} program supply voltage

V_{PPF} is both a flash memory control input and a flash memory power supply pin. The two functions are selected by the voltage range applied to the pin.

If V_{PPF} is kept in a low voltage range (0 V to V_{DDQ}) V_{PPF} is seen as a control input. In this case a voltage lower than V_{PPLKF} provides absolute protection against program or erase, while VPPF > VPP1F enables these functions (see the M58WR032KT/B and M58WR064KT/B datasheet for the relevant values). V_{PPF} is only sampled at the beginning of a program or erase; a change in its value after the operation has started does not have any effect and program or erase operations continue.

If V_{PPF} is in the range of V_{PPHF} it acts as a power supply pin. In this condition V_{PPF} must be stable until the program/erase algorithm is completed.

2.20 V_{SS} ground

 $V_{\rm SS}$ is the common ground reference for all voltage measurements in the flash (core and I/O buffers) and PSRAM chips.

Note:

Each flash memory device in a system should have its supply voltage (V_{DDF}) and the program supply voltage V_{PPF} decoupled with a 0.1 μ F ceramic capacitor close to the pin (high-frequency, inherently-low inductance capacitors should be as close as possible to the package). See Figure 5: AC measurement load circuit. The PCB track widths should be sufficient to carry the required V_{PPF} program and erase currents.

√ numonyx 13/24

3 Functional description

The flash memory and PSRAM components have separate power supplies but share the same grounds. They are distinguished by two Chip Enable inputs: \overline{E}_F for the flash memory and \overline{E}_P for the PSRAM.

Recommended operating conditions do not allow more than one device to be active at a time. The most common example is simultaneous read operations on the flash memory and the PSRAM which would result in a data bus contention. Therefore, it is recommended to put the other devices in the high impedance state when reading the selected device.

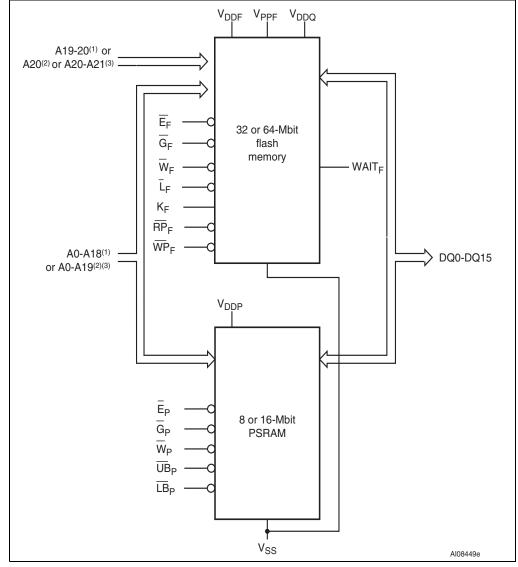


Figure 3. Functional block diagram

- 1. Address inputs corresponding to the M36W0R5030x7 devices.
- 2. Address inputs corresponding to the M36W0R5040x7 devices.
- 3. Address inputs corresponding to the M36W0R6040x7 devices.

Table 3. Main operating modes⁽¹⁾

	name of main operating mouse											
Operation	Ē _F	\overline{G}_{F}	\overline{W}_{F}	L	\overline{RP}_F	WAIT ⁽²⁾	Ē _P	$\overline{E}_P \mid \overline{G}_P \mid \overline{W}_P \mid \overline{UB}_P \mid \overline{LB}_P$		∐B _P	DQ15-DQ0	
Flash read	V_{IL}	V_{IL}	V_{IH}	V _{IL} (3)	V _{IH}							Flash data out
Flash write	V_{IL}	V_{IH}	V_{IL}	V _{IL} (3)	V _{IH}							Flash data in
Flash address latch	V _{IL}	Х	V _{IH}	V _{IL}	V _{IH}		PSRAM must be disabled Flash data out or Hi Z ⁽⁴⁾				Flash data out or Hi-	
Flash output disable	V _{IL}	V _{IH}	V _{IH}	Х	V _{IH}		Flash Hi-Z				Flash Hi-Z	
Flash standby	V _{IH}	Х	Х	Х	V _{IH}	Hi-Z	Α	ny PS	SRAM	mode	is	Flash Hi-Z
Flash reset	Х	Х	Х	Х	V _{IL}	Hi-Z		ä	allowe	d		Flash Hi-Z
PSRAM read		Elach	momo	on, muct	ho dica	blod	V _{IL}	V _{IL}	V_{IH}	V _{IL}	V_{IL}	PSRAM data out
PSRAM write	Flash memory must be disabled $V_{IL} \times V_{IL} \times V_{IL}$						V _{IL}	V_{IL}	PSRAM data in			
PSRAM standby							V _{IH}	Х	Х	Х	Χ	PSRAM Hi-Z
PSRAM deep power-down	Any flash mode is allowed. V _{IH} X						Х	Х	Х	Х	PSRAM Hi-Z	

^{1.} X = 'don't care'.

16/24 № numonyx

^{2.} WAIT signal polarity is configured using the Set Configuration Register command. Refer to M58WR032KT/B and M58WR064KT/B datasheet for details.

^{3.} \overline{L} can be tied to V_{IH} if the valid address has been previously latched.

^{4.} Depends on \overline{G}_F .

M36W0Rx0x0x7 Maximum ratings

4 Maximum ratings

Stressing the device above the rating listed in *Table 4: Absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. Absolute maximum ratings

Symbol	Parameter	Va	Unit	
Symbol	Farameter	Min	Max	Oill
T _A	Ambient operating temperature	-40	85	°C
T _{BIAS}	Temperature under bias	-40	125	°C
T _{STG}	Storage temperature	– 55	125	°C
V _{IO}	Input or output voltage	-0.5	3.3	V
V_{DDF}	Flash memory core supply voltage	-0.2	2.45	V
V _{DDQ}	Input/output supply voltage	-0.2	2.45	V
V _{DDP}	PSRAM supply voltage	-0.5	3.3	V
V _{PPF}	Flash memory program voltage	-0.2	10	V
Io	Output short circuit current		100	mA
t _{VPPFH}	Time for V _{PPF} at V _{PPFH}		100	hours

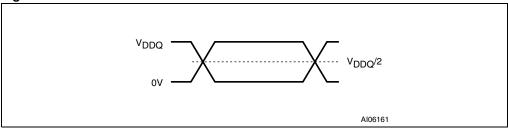
5 DC and AC parameters

This section summarizes the operating measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC characteristics tables in this section are derived from tests performed under the measurement conditions summarized in *Table 5*. Designers should check that the operating conditions in their circuit match the operating conditions when relying on the quoted parameters.

Table 5. Operating and AC measurement conditions

Parameter	Flash	memory	PSF	Unit	
raiametei	Min	Max	Min	Max	Oille
V _{DDF} supply voltage	1.7	1.95	-	-	V
V _{DDP} supply voltage	-	-	1.7	1.95	V
V _{DDQ} supply voltage	1.7	1.95	_	-	V
V _{PPF} supply voltage (factory environment)	8.5	9.5	ı	_	V
V _{PPF} supply voltage (application environment)	-0.4	V _{DDQ} +0.4	_	_	V
Ambient operating temperature	-40	85	-40	85	°C
Load capacitance (C _L)	;	30	5	0	pF
Input rise and fall times		5		2	ns
Input pulse voltages	0 to	V_{DDQ}	0 to	V	
Input and output timing ref. voltages	V _D	_{DQ} /2	V _{DI}	_{DP} /2	V

Figure 4. AC measurement I/O waveform



18/24 № numonyx

VDDF VDDQ VDDQ VDDQ VDDQ VDDQ DEVICE UNDER TEST C_L $22k\Omega$ C_L includes JIG capacitance

Figure 5. AC measurement load circuit

Table 6. Device capacitance⁽¹⁾

Symbol	Parameter Test condition			Max	Unit
C _{IN}	Input capacitance	V _{IN} = 0 V		12	pF
C _{OUT}	Output capacitance	V _{OUT} = 0 V		15	pF

^{1.} Sampled only, not 100% tested.

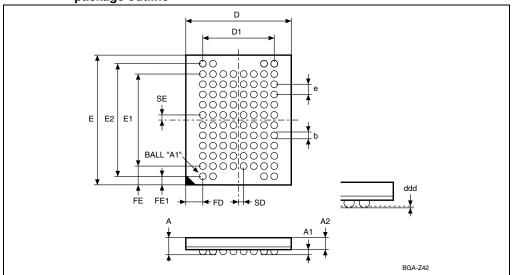
Please refer to the M58WR032KT/B and M58WR064KT/B and M69KB012AB or M69KB024AB datasheets for further DC and AC characteristics values and illustrations.

6 Package mechanical

To meet environmental requirements, Numonyx offers the M36W0R50x0x7 and M36W0R6040x7 in RoHS compliant packages, which have a lead-free second-level interconnect. In compliance with JEDEC standard JESD97, the category of second-level interconnect is marked on the package and on the inner box label. The maximum ratings related to soldering conditions are also marked on the inner box label.

Note: RoHS compliant specifications are available at www.numonyx.com.

Figure 6. Stacked TFBGA88 8 x 10 mm - 8 x 10 active ball array, 0.8 mm pitch, package outline



1. Drawing is not to scale.

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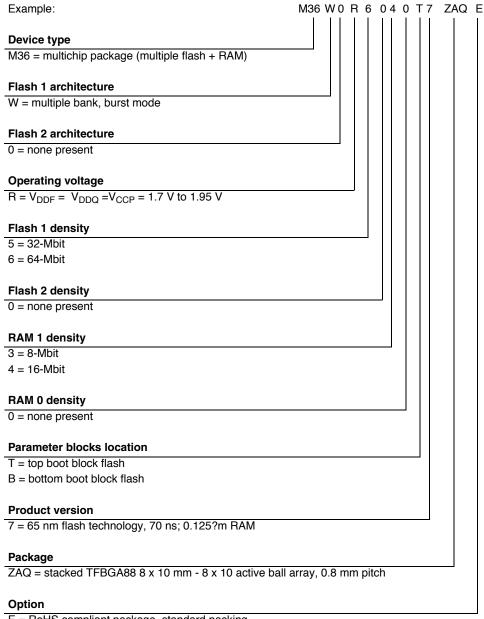
Table 7. Stacked TFBGA88 8 x 10 mm - 8 x 10 ball array, 0.8 mm pitch, package mechanical data

Symbol		Millimeters			Inches	
Symbol	Тур	Min	Max	Тур	Min	Max
Α			1.200			0.0472
A1		0.200			0.0079	
A2	0.850			0.0335		
b	0.350	0.300	0.400	0.0138	0.0118	0.0157
D	8.000	7.900	8.100	0.3150	0.3110	0.3189
D1	5.600			0.2205		
ddd			0.100			0.0039
Е	10.000	9.900	10.100	0.3937	0.3898	0.3976
E1	7.200			0.2835		
E2	8.800			0.3465		
е	0.800	-	-	0.0315	-	-
FD	1.200			0.0472		
FE	1.400			0.0551		
FE1	0.600			0.0236		
SD	0.400			0.0157		
SE	0.400			0.0157		

Part numbering M36W0Rx0x0x7

7 Part numbering

Table 8. Ordering information scheme



E = RoHS compliant package, standard packing

F = RoHS compliant package, tape and reel packing

Devices are shipped from the factory with the memory content bits erased to '1'. For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact the Numonyx sales office nearest to you.

22/24 **№** numonyx

M36W0Rx0x0x7 Revision history

8 Revision history

Table 9. Document revision history

Date	Version	Revision Details
30-Jun-2008	1	Initial release.
29-Sep-2008	2	Change from T=-30°C to T=-40°C.
31-Mar-2009 3		Replaced references to ECOPACK with RoHS compliant. Changed footnote 1 in figure1.

Numonyx 23/24

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